

2nd International Workshop on Soft X-ray Single-order Diffraction Grating Technology and Application

Friday, October 18, 2019

Beam Monochromatic and Applications - Chair: Leifeng Cao - Conference Room, 3rd floor (9:15 AM - 10:15 AM)

time	[id] title	presenter
9:15 AM	M1] Reflectance measurements and analysis of EUV multilayers on the SDG beamline of BSRF (25'+5')	CUI, Mingqi
9:45 AM	M2] Polarization Measurement of the SDG Beamline of BSRF Based on Multilayer in VUV and EUV Range (25'+5')	Prof. ZHU, Jingtao